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| Notice of References Cited | | Application/Control No. 10/612,211 | Applicant(s)/Patent Under Reexamination VAN DAMME ET AL. | |
| | | Examiner Barbara L. Gilliam | Art Unit 1752 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-2003/0232281 A1 | 12-2003 | Watanabe et al. | 430/302 |
| | B | US-2003/0068578 A1 | 04-2003 | Van Damme et al. | 430/272.1 |
| | C | US-2003/0031951 A1 | 02-2003 | Aburano, Maru | 430/270.1 |
| | D | US-2002/0094490 A1 | 07-2002 | Endo et al. | 430/278.1 |
| | E | US-2002/0058207 A1 | 05-2002 | URANO et al. | 430/302 |
| | F | US-6,514,656 B1 | 02-2003 | Nakamura et al. | 430/157 |
| | G | US-6,458,510 B1 | 10-2002 | Vermeersch et al. | 430/302 |
| | H | US-6,455,229 B1 | 09-2002 | Vermeersch et al. | 430/302 |
| | I | US-6,489,079 B1 | 12-2002 | Verschueren et al. | 430/270.1 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
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NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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